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<b>Application Number</b>	10/086,025
<b>Filing Date</b>	February 28, 2002
<b>First Named Inventor</b>	Marc R. Anderson
<b>Group Art Unit</b>	1743
<b>Examiner Name</b>	
<b>Attorney Docket Number</b>	286697-00005

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Sheet 1 of 1

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**Examiner  
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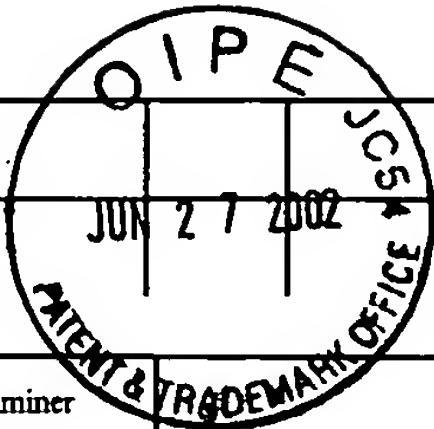
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* AS		FASSETT et al., <i>Determination of Nanogram Quantities of Vanadium in Biological Material by Isotope Dilution Thermal Ionization Mass Spectrometry with Ion Counting Detection</i> , Anal. Chem. (November 1985), pp. 2474-2478, V57, No. 13.	
* AS		FASSETT et al., <i>Isotope Dilution Mass Spectrometry for Accurate Elemental Analysis</i> , Anal. Chem. (May 15, 1989), pp. 643A-649A V61, No. 10.	
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* AS		ROTTMANN et al., <i>Development of an on-line isotope dilution technique with HPLC/ICP-MS for the accurate determination of elemental species</i> , Fresenius J. Anal Chem. (1994), pp. 221-227, V350.	
AS		COLE, <i>Electrospray Ionization Mass Spectrometry: Fundamentals, Instrumentation and Applications</i> , John Wiley & Sons, Inc. (1997), New York.	
AS		STEWART, <i>Electrospray mass spectrometry: a tool for elemental speciation</i> , Spectrochimica, Acta. (1999), pp. 1649-1695, Part-B, Vol. 54.	
* AS		<i>International Technology Roadmap for Semiconductors 1999 Edition: Defect Reduction</i> , Sematech, Austin, TX, pp. 269-293.	
AS		NEWTON et al., <i>Analysis of Copper Plating Baths – Suppressors and Levelers</i> , Electrochemical Society Proceedings, pp. 1-5, V2000-27.	

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